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Cypress Semiconductor Package Qualification Report

**QTP# 163503 VERSION **
December 2016**

**54L TSOP (22.4x11.84x1.0mm)
Matte Sn leadfinish, Au Wire
MSL3, 260C Reflow
Chipmos-Taiwan (GM)**

**FOR ANY QUESTIONS ON THIS REPORT, PLEASE CONTACT
reliability@cypress.com or via a CYLINK CRM CASE**

Prepared By:
Honesto Sintos
Reliability Engineer

Reviewed By:
Rene Rodgers
Reliability Manager

Approved By:
David Hoffman
Reliability Director

PACKAGE QUALIFICATION HISTORY

QTP Number	Description of Qualification Purpose	Date
163503	Qualification of 54L-TSOP II (22.4x11.84x1.0mm) Package in Chipmos-Taiwan (GM) using 0.7mil Au wire with Hitachi CEL-9200HF-U mold compound, Hitachi EN4900 die attach material, Cu leadframe and Matte Sn at MSL3, 260C Reflow Temperature	Dec 2016

MAJOR PACKAGE INFORMATION USED IN THIS QUALIFICATION	
Package Designation:	ZW54
Package Outline, Type, or Name:	54L-TSOP II 22.4x11.84x1.0mm
Mold Compound Name/Manufacturer:	CEL-9200HF-U / Hitachi
Mold Compound Flammability Rating:	N/A
Mold Compound Alpha Emission Rate:	max. 0.0050 count/cm ²
Oxygen Rating Index: >28%	N/A
Lead Frame Designation:	Full Metal Pad
Lead Frame Material:	Copper
Substrate Material:	N/A
Lead Finish, Composition / Thickness:	Matte Sn
Die Backside Preparation Method/Metallization:	Wafer Backgrind
Die Separation Method:	Wafer Saw
Die Attach Supplier:	Hitachi
Die Attach Material:	EN4900
Bond Diagram Designation	002-12014
Wire Bond Method:	Thermosonic
Wire Material/Size:	Au / 0.7 mil
Thermal Resistance Theta JA °C/W:	36.7 for 7C14104C 40.1 for 7C17165A
Package Cross Section Yes/No:	Yes
Assembly Process Flow:	49-77999
Name/Location of Assembly (prime) facility:	Chipmos-Taiwan (GM)
MSL LEVEL	3
REFLOW PROFILE	260C

ELECTRICAL TEST / FINISH DESCRIPTION	
Test Location:	CML-Philippines (R), Chipmos-Taiwan (GO)

Note: Please contact a Cypress Representative for other package availability.

RELIABILITY TESTS PERFORMED PER SPECIFICATION REQUIREMENTS

Stress/Test	Test Condition (Temp/Bias)	Result P/F
High Accelerated Saturation Test (HAST)	JESD22-A110, 130C, 3.65V, 85%RH Precondition: JESD22-A113 Moisture Sensitivity MSL 3 192 Hrs, 30C/60%RH+3IR-Reflow, 260°C+0, -5°C	P
Temperature Cycle	JESD22-A104, -65°C to 150°C Precondition: JESD22-A113 Moisture Sensitivity MSL 3 192 Hrs, 30C/60%RH+3IR-Reflow, 260°C+0, -5°C	P
Pressure Cooker	JESD22-A102, 121C, 100%RH, 15 Psig Precondition: JESD22-A113 Moisture Sensitivity MSL 3 192 Hrs, 30C/60%RH+3IR-Reflow, 260°C+0, -5°C	P
Acoustic	J-STD-020 Precondition: JESD22-A113 Moisture Sensitivity MSL 3 192 Hrs, 30C/60%RH+3IR-Reflow, 260C+0, -5C	P
X-Ray	MIL-STD-883 – 2012	P
Final Visual Inspection	JESD22-B101B	P
Ball Shear	JESD22-B116A	P
Bond Pull	Mil-Std 883, Method 2011	P
Electrostatic Discharge Charge Device Model (ESD-CDM)	500V, JESD22-C101	P
Physical Dimension	MIL-STD-1835, JESD22-B100	P
Constructional Analysis	Criteria: Meet external and internal characteristics of Cypress package	P
Solderability	JESD22-B102	P



Reliability Test Data

QTP #: 163503

<i>Device</i>	<i>Package</i>	<i>Fab Lot #</i>	<i>Assy Lot #</i>	<i>Assy Loc</i>	<i>Duration</i>	<i>Samp</i>	<i>Rej</i>	<i>Failure Mechanism</i>
STRESS: ACOUSTIC, MSL3								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	15	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	15	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	15	0	
STRESS: BALL SHEAR								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	10	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	10	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	10	0	
STRESS: BOND PULL								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	10	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	10	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	10	0	
STRESS: CONSTRUCTIONAL ANALYSIS								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	5	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	5	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	5	0	
STRESS: DIE SHEAR								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	10	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	10	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	10	0	
STRESS: ESD-CDM								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	500	9	0	
STRESS: FINAL VISUAL INSPECTION								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	898	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	899	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	873	0	
STRESS: HI-ACCEL SATURATION TEST, 130C, 3.65V, 85%RH, PRE COND 192 HR 30C/60%RH, MSL3								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	96	30	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	96	30	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	96	30	0	

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Reliability Test Data

QTP #: 163503

<i>Device</i>	<i>Package</i>	<i>Fab Lot #</i>	<i>Assy Lot #</i>	<i>Assy Loc</i>	<i>Duration</i>	<i>Samp</i>	<i>Rej</i>	<i>Failure Mechanism</i>
STRESS: PHYSICAL DIMENSION								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	10	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	10	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	10	0	
STRESS: PRESSURE COOKER TEST								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	168	79	0	
STRESS: SOLDERABILITY								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	3	0	
STRESS: TC COND. C -65C TO 150C, PRECONDITION 192 HRS 30C/60%RH								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	500	80	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	1000	80	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	500	80	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	1000	80	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	500	80	0	
STRESS: X-RAY								
CY7C1069G (7C171069A)	ZW54	9511008	611630646	GM-T	COMP	15	0	
CY7C1069G (7C171069A)	ZW54	9511008	611630647	GM-T	COMP	15	0	
CY14B104M (7C1404B2C)	ZW54	4551256	611628480	GM-T	COMP	15	0	



Document History Page

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Rev.	ECN No.	Orig. of Change	Description of Change
**	5554828	HSTO	Initial spec release